

# AM3949P-T1-PF-VB Datasheet Dual P-Channel 60-V (D-S) MOSFET

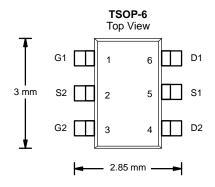
PRODUCT SUMMARY						
V <sub>DS</sub> (V)	$R_{DS(on)}$ ( $\Omega$ ) Typ.	I <sub>D</sub> (A) <sup>d</sup>	Q <sub>g</sub> (TYP.)			
-60	0.070 at V <sub>GS</sub> = -10 V	-4.5	10.1 nC			
	0.085 at V <sub>GS</sub> = -4.5 V	-4.0	10.1110			

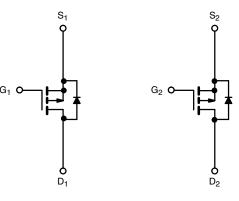
## **FEATURES**

- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET<sup>®</sup> Power MOSFET
- Compliant to RoHS Directive 2002/95/EC









P-Channel MOSFET

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<b>ABSOLUTE MAXIMUM RATINGS</b> (TA	= 25 °C, unless other	wise noted)		
PARAMETER	SYMBOL	LIMIT	UNIT	
Drain-Source Voltage	V <sub>DS</sub>	-60	V	
Gate-Source Voltage		V <sub>GS</sub>	± 20	V
	T <sub>C</sub> = 25 °C		-4.5	
Continuous Drain Current (T. 150 °C)	T <sub>C</sub> = 70 °C	1 , 🗀	-4.0	
Continuous Drain Current (T <sub>J</sub> = 150 °C)	T <sub>A</sub> = 25 °C	I <sub>D</sub>	-3.5 <sup>a,b</sup>	
	T <sub>A</sub> = 70 °C		-3.0 <sup>a,b</sup>	
Pulsed Drain Current (t = 100 µs)	<u>.</u>	I <sub>DM</sub>	-20	A
Continuous Course Dunin Diada Course	T <sub>C</sub> = 25 °C		-3.9	
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	I <sub>S</sub>	-2.1 <sup>a,b</sup>	
Avalanche Current	1 0111	I <sub>AS</sub>	-15	
Single-Pulse Avalanche Energy	L = 0.1 mH	E <sub>AS</sub>	11.25	mJ
	T <sub>C</sub> = 25 °C		4.2	
Mariana Darra Dissipation	T <sub>C</sub> = 70 °C	1 ,	2.7	14/
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	P <sub>D</sub>	2 <sup>a,b</sup>	W
	T <sub>A</sub> = 70 °C		1.3 <sup>a,b</sup>	
Operating Junction and Storage Temperature Rang	T <sub>J</sub> , T <sub>stg</sub>	-55 to 150	°C	

THERMAL RESISTANCE RATINGS							
PARAMETER	SYMBOL	TYPICAL	MAXIMUM	UNIT			
Maximum junction-to-ambient <sup>a</sup>	t ≤ 5 s	R <sub>thJA</sub>	100	130	°C/W		
Maximum junction-to-case (drain)	Steady state	$R_{thJF}$	60	75	] C/VV		

#### Notes

- a. Surface mounted on 1" x 1" FR4 board.
- h t 10 s
- c. Maximum under steady state conditions is 110 °C/W.
- d. Based on  $T_C = 25 \,^{\circ}C$ .

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PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static				I.	l		
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$		-	-	V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	——— In = -250 µA ⊢		-6.7	-	mV/°C	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$			4.3	-		
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_D = -250 \mu A$	-1	-	-3	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	-	-	± 100	nA	
Zana Cata Valta da Busin Comunat	1	V <sub>DS</sub> = -60 V, V <sub>GS</sub> = 0 V		-	-1		
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = -60 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C	-	-	-5	μΑ	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge -10 \text{ V}, V_{GS} = -10 \text{ V}$	-30	-	-	Α	
Durin On the On Olate Business 3	Б	V <sub>GS</sub> = -10 V, I <sub>D</sub> = -3.5 A	-	0.070	-		
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = -4.5 V, I <sub>D</sub> = -2.8 A	-	0.085	-	Ω	
Forward Transconductance a	9 <sub>fs</sub>	$V_{DS} = -30 \text{ V}, I_D = -3.5 \text{ A}$	-	11	-	S	
Dynamic <sup>b</sup>				I.	l		
Input Capacitance	C <sub>iss</sub>		-	832	-		
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = -30 V, V <sub>GS</sub> = 0 V, f = 1 MHz		88	-	pF	
Reverse Transfer Capacitance	C <sub>rss</sub>		-	63	-		
Tabal Cada Obassa	Q <sub>g</sub>	$V_{DS} = -30 \text{ V}, V_{GS} = -10 \text{ V}, I_D = -3.5 \text{ A}$	-	20	30	nC	
Total Gate Charge			-	10.1	15.2		
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS} = -30 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -3.5 \text{ A}$	-	3.3	-		
Gate-Drain Charge	Q <sub>gd</sub>		-	3.9	-		
Gate Resistance	R <sub>g</sub>	f = 1 MHz	1.8	9	18	Ω	
Turn-On Delay Time	t <sub>d(on)</sub>		-	8	16		
Rise Time	t <sub>r</sub>	$V_{DD} = -30 \text{ V}, R_{L} = 10.7 \Omega$	-	6	12	1	
Turn-Off DelayTime	t <sub>d(off)</sub>	$I_D \cong -2.8 \text{ A}, V_{GEN} = -10 \text{ V}, R_g = 1 \Omega$		35	53		
Fall Time	t <sub>f</sub>		-	16	24		
Turn-On Delay Time	t <sub>d(on)</sub>		-	40	60	ns	
Rise Time	t <sub>r</sub>	$V_{DD} = -30 \text{ V}, R_{L} = 10.7 \Omega$	-	28	42	<del>-</del> - -	
Turn-Off DelayTime	t <sub>d(off)</sub>	$I_D \cong -2.8 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_g = 1 \Omega$	-	31	47		
Fall Time	t <sub>f</sub>		-	15	23		
Drain-Source Body Diode Characterist	ics						
Continous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C	-	-	-3.5		
Pulse Diode Forward Current (t = 100 µs)	I <sub>SM</sub>		-	-	-20	A	
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = -2.8 A, V <sub>GS</sub> = 0 V	-	-0.85	-1.2	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>		-	32	48	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	I <sub>F</sub> = -2.8 A, dl/dt = 100 A/μs,	-	45	68	nC	
Reverse Recovery Fall Time $t_a$ $T_J = 25 ^{\circ}\text{C}$ Reverse Recovery Rise Time $t_b$			-	24	-		
		-	8	-	ns		

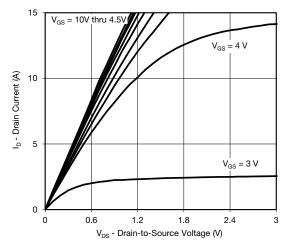
#### Notes

- a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

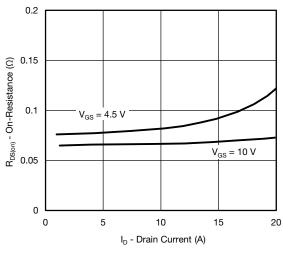
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



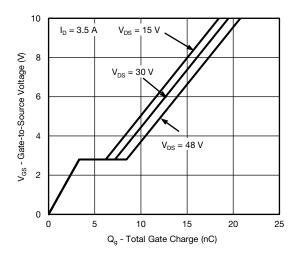
## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



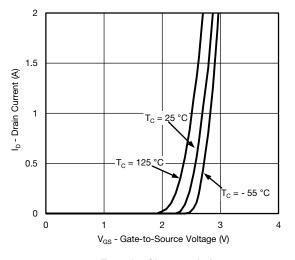




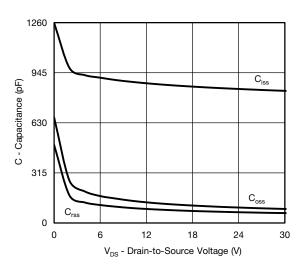
On-Resistance vs. Drain Current



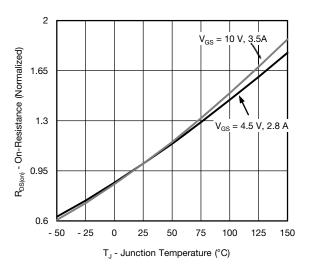
**Gate Charge** 



**Transfer Characteristics** 



Capacitance

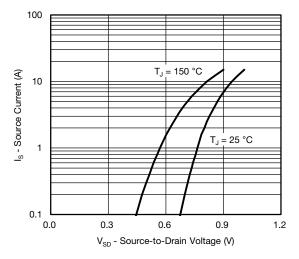


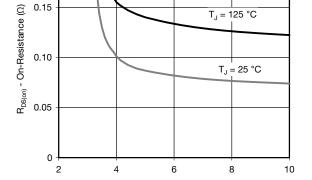
On-Resistance vs. Junction Temperature



 $I_D = 3.5 A$ 

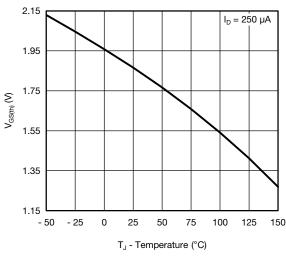
## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

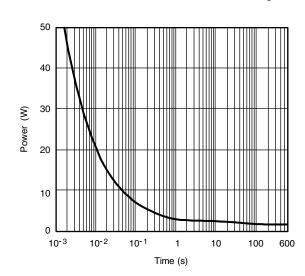




#### Source-Drain Diode Forward Voltage

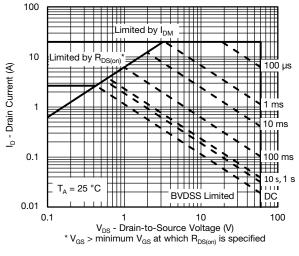
 $\label{eq:VGS} V_{GS} \mbox{-} \mbox{Gate-to-Source Voltage (V)}$   $\mbox{On-Resistance vs. Gate-to-Source Voltage}$ 





Threshold Voltage

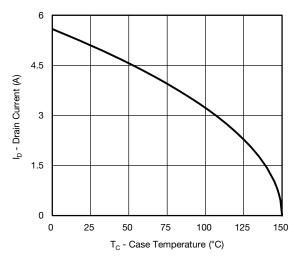
Single Pulse Power, Junction-to-Ambient



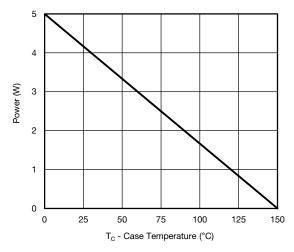
Safe Operating Area



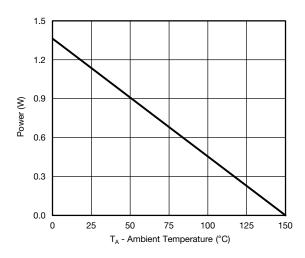
## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



#### **Current Derating\***





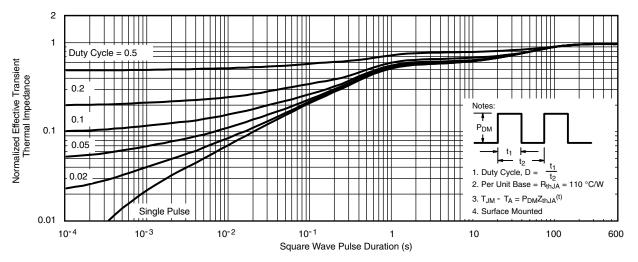


Power Derating, Junction-to-Ambient

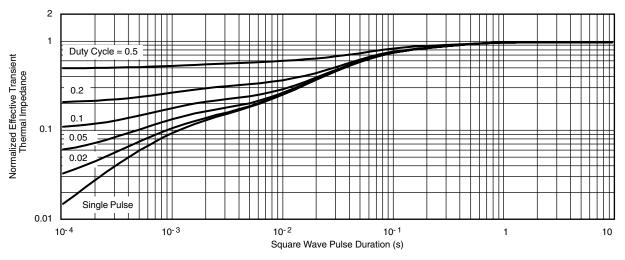
<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J \text{ (max.)}} = 150 \,^{\circ}\text{C}$ , using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient

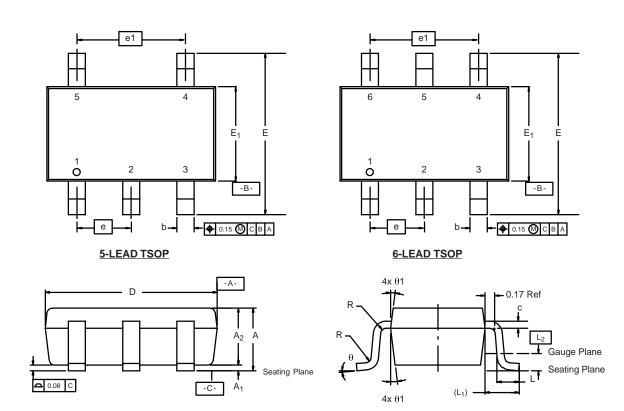


Normalized Thermal Transient Impedance, Junction-to-Foot



TSOP: 5/6-LEAD

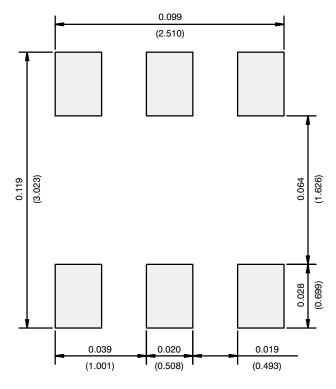
**JEDEC Part Number: MO-193C** 



	MILLIMETERS			INCHES			
Dim	Min	Nom	Max	Min	Nom	Max	
Α	0.91	-	1.10	0.036	-	0.043	
A <sub>1</sub>	0.01	-	0.10	0.0004	-	0.004	
A <sub>2</sub>	0.90	-	1.00	0.035	0.038	0.039	
b	0.30	0.32	0.45	0.012	0.013	0.018	
С	0.10	0.15	0.20	0.004	0.006	0.008	
D	2.95	3.05	3.10	0.116	0.120	0.122	
Е	2.70	2.85	2.98	0.106	0.112	0.117	
E <sub>1</sub>	1.55	1.65	1.70	0.061	0.065	0.067	
е	0.95 BSC			0.0374 BSC			
e <sub>1</sub>	1.80	1.90	2.00	0.071	0.075	0.079	
L	0.32	-	0.50	0.012	-	0.020	
L <sub>1</sub>	0.60 Ref			0.024 Ref			
L <sub>2</sub>	0.25 BSC			0.010 BSC			
R	0.10	-	-	0.004	-	-	
θ	0°	4°	8°	0°	4°	8°	
θ1	7° Nom 7° Nom						
ECN: C-06593-Rev. I, 18-Dec-06 DWG: 5540							



## **RECOMMENDED MINIMUM PADS FOR TSOP-6**



Recommended Minimum Pads Dimensions in Inches/(mm)



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